

## **Data Sheet**

### FEATURES

7.5 GHz operating frequency
160 ps propagation delay
100 ps output rise/fall
110 fs random jitter
On-chip input terminations
Extended industrial temperature range: -40°C to +125°C
3.3 V power supply (V<sub>CC</sub> - V<sub>EE</sub>)

#### **APPLICATIONS**

Clock and data signal restoration High speed converter clocking Broadband communications Cellular infrastructure High speed line receivers ATE and high performance instrumentation Level shifting Threshold detection

#### **GENERAL DESCRIPTION**

The ADCLK914 is an ultrafast clock/data buffer fabricated on the Analog Devices, Inc., proprietary, complementary bipolar (XFCB-3) silicon-germanium (SiGe) process. The ADCLK914 features high voltage differential signaling (HVDS) outputs suitable for driving the latest Analog Devices high speed digitalto-analog converters (DACs). The ADCLK914 has a single, differential open-collector output.

The ADCLK914 buffer operates up to 7.5 GHz with a 160 ps propagation delay and adds only 110 fs random jitter (RJ).

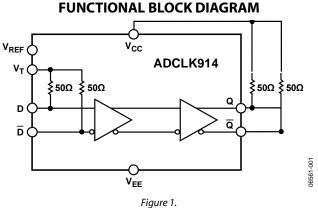
The input has a center tapped, 100  $\Omega$ , on-chip termination resistor and accepts LVPECL, CML, CMOS, LVTTL, or LVDS (ac-coupled only). A V<sub>REF</sub> pin is available for biasing ac-coupled inputs.

The HVDS output stage is designed to directly drive 1.9 V each side into 50  $\Omega$  terminated to  $V_{\rm CC}$  for a total differential output swing of 3.8 V.

The ADCLK914 is available in a 16-lead LFCSP. It is specified for operation over the extended industrial temperature range of  $-40^{\circ}$ C to  $+125^{\circ}$ C.

ADCLK914

**HVDS Clock/Data Buffer** 



Ultrafast, SiGe, Open-Collector

#### Rev. B

#### Document Feedback

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### **REVISION HISTORY**

9/2017—Rev. A to Rev. B	
Updated Outline Dimensions	11
Changes to Ordering Guide	11

#### 10/2008—Rev. 0 to Rev. A

Changes to Input Low Voltage Parameter, Table 1	3
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Output Differential Range Parameter, Table 1	3
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#### 7/2008—Revision 0: Initial Version

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## **SPECIFICATIONS**

## **ELECTRICAL CHARACTERISTICS**

 $V_{CC}$  = 3.3 V,  $V_{EE}$  = 0 V,  $T_A$  = -40°C to +125°C. All outputs terminated through 50  $\Omega$  to  $V_{CC}$ , unless otherwise noted.

Parameter	Symbol	Min	Тур	Max	Unit	Test Conditions/Comments
DC INPUT CHARACTERISTICS	-					
Input High Voltage	VIH	V <sub>EE</sub> + 1.65		Vcc	V	
Input Low Voltage	VIL	V <sub>EE</sub>		V <sub>cc</sub> – 0.2	V	
Input Differential Range	VID	0.2		3.4	V р-р	$T_A = -40^{\circ}C$ to $+85^{\circ}C$ (±1.7 V between input pins)
		0.2		2.8	V р-р	T <sub>A</sub> = 85°C to 125°C (±1.4 V between input pins)
Input Capacitance	CIN		0.4		pF	
Input Resistance			50		Ω	
Differential Mode			100		Ω	
Common Mode			50		kΩ	Open termination
Input Bias Current			20		μA	
DC OUTPUT CHARACTERISTICS			-		1°	
Output High Voltage	V <sub>он</sub>	Vcc – 0.55	V <sub>cc</sub> – 0.40	Vcc – 0.25	V	
Output Low Voltage	Vol	V <sub>cc</sub> – 2.75	V <sub>cc</sub> – 2.35	Vcc – 1.9	V	
Output Differential Range	Vod	1.54	1.95	2.22	V	
Reference Voltage	VREF					
Output Voltage			$(V_{cc} + 1)/2$		V	–500 μA to +500 μA
Output Resistance			250		Ω	
AC PERFORMANCE						
Operating Frequency			7.5		GHz	>1.1 V differential output swing, $V_{CC} = 3.3 V \pm 10\%$
Propagation Delay	<b>t</b> PD	127	158	202	ps	$V_{CC} = 3.3 \text{ V} \pm 10\%, V_{ICM} = V_{REF}, \\ V_{ID} = 1.6 \text{ V } p\text{-}p$
Propagation Delay Temperature Coefficient			140		fs/°C	
Propagation Delay Skew (Device to Device)				65	ps	V <sub>ID</sub> = 1.6 V p-p
Output Rise Time	t <sub>R</sub>		100	125	ps	20%/80%
Output Fall Time	t <sub>F</sub>		80	95	ps	80%/20%
Wideband Random Jitter <sup>1</sup> Additive Phase Noise	RJ		110		fs rms	$V_{ID} = 1.6 \text{ V p-p}, 6 \text{ V/ns}, V_{ICM} = 1.85 \text{ V}$
622.08 MHz			-132		dBc/Hz	@10 Hz offset
			-143		dBc/Hz	@100 Hz offset
			-151		dBc/Hz	@1 kHz offset
			-156		dBc/Hz	@10 kHz offset
			-157		dBc/Hz	@100 kHz offset
			-156		dBc/Hz	>1 MHz offset
245.76 MHz			-133		dBc/Hz	@10 Hz offset
			-143		dBc/Hz	@100 Hz offset
			-153		dBc/Hz	@1 kHz offset
			-158		dBc/Hz	@10 kHz offset
			-159		dBc/Hz	@100 kHz offset
			-158		dBc/Hz	>1 MHz offset

Parameter	Symbol	Min	Тур	Max	Unit	Test Conditions/Comments
122.88 MHz			-150		dBc/Hz	@10 Hz offset
			-156		dBc/Hz	@100 Hz offset
			-160		dBc/Hz	@1 kHz offset
			-161		dBc/Hz	@10 kHz offset
			-161		dBc/Hz	@100 kHz offset
			-160		dBc/Hz	>1 MHz offset
POWER SUPPLY						
Supply Voltage Requirement	Vcc	2.97		3.63	V	
Power Supply Current						
Negative Supply Current	IVEE	66	111	150	mA	Includes output current
Positive Supply Current	lvcc	34	55	73	mA	
Power Supply Rejection <sup>2</sup>	PSRvcc		13		ps/V	$V_{CC} = 3.3 V \pm 10\%$
Output Swing Supply Rejection <sup>3</sup>			-15		dB	$V_{CC} = 3.3 V \pm 10\%$

 $^1$  Calculated from SNR of ADC method. See Figure 8 for rms jitter vs. input slew rate.  $^2$  Change in  $t_{PD}$  per change in  $V_{cc}$ .  $^3$  Change in output swing per change in  $V_{cc}$ .

## **ABSOLUTE MAXIMUM RATINGS**

#### Table 2.

Parameter	Rating
Supply Voltage (V <sub>cc</sub> to GND)	6.0 V
Input Voltage	-0.5 V to Vcc + 0.5 V
Maximum Output Voltage	Vcc + 0.5 V
Minimum Output Voltage	$V_{\text{EE}} - 0.5 \text{ V}$
Input Termination	±2 V
Voltage Reference	$V_{CC} - V_{EE}$
Operating Temperature Range, Ambient	-40°C to +125°C
Operating Temperature, Junction	150°C
Storage Temperature Range	-65°C to +150°C

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

#### THERMAL PERFORMANCE

The ADCLK914 is specified for a case temperature ( $T_{CASE}$ ). To ensure that  $T_{CASE}$  is not exceeded, use an airflow source.

To determine the junction temperature on the application PCB

 $T_J = T_{CASE} + (\Psi_{JT} \times PD)$ 

where:

T<sub>J</sub> is the junction temperature (°C).

 $T_{CASE}$  is the case temperature (°C) measured by the customer at top center of package.

 $\Psi_{\text{JT}}$  is determined by the values listed in Table 3.

PD is the power dissipation.

Values of  $\theta_{JA}$  are provided for package comparison and PCB design considerations.  $\theta_{JA}$  can be used for a first-order approximation of  $T_J$  by the equation

 $T_J = T_A + (\theta_{JA} \times PD)$ 

where  $T_A$  is the ambient temperature (°C).

Values of  $\theta_{IB}$  are provided for package comparison and PCB design considerations.

Table 3. Thermal Parameters for ADCLK914 16-Lead LFCSP

Symbol	Description <sup>1</sup>	Value	Units
ALθ	Junction-to-ambient thermal resistance, 0.0 meters per sec air flow per JEDEC JESD51-2 (still air)	78.4	°C/W
АМЕ	Junction-to-ambient thermal resistance, 1.0 meter per sec air flow per JEDEC JESD51-6 (moving air)	68.5	°C/W
θ <sub>JMA</sub>	Junction-to-ambient thermal resistance, 2.5 m/s air flow per JEDEC JESD51-6 (moving air)	61.4	°C/W
$\theta_{JB}$	Junction-to-board thermal resistance, 1.0 meter per sec air flow per JEDEC JESD51-8 (moving air)	48.8	°C/W
θ <sub>JC</sub>	Junction-to-case thermal resistance (die-to-heatsink) per MIL-Std 883, Method 1012.1	1.5	°C/W
Ψ,π	Junction-to-top-of-package characterization parameter, 0 meters per sec air flow per JEDEC JESD51-2 (still air)	2.0	°C/W

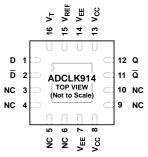
<sup>1</sup> Descriptions based on using a 2s2p test board.

#### **ESD CAUTION**



**ESD** (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

## **PIN CONFIGURATION AND FUNCTION DESCRIPTIONS**



NOTES 1. NC = NO CONNECT. NO PHYSICAL CONNECTION TO THE DIE. 2. EXPOSED PAD. NO CONNECT. THE METALLIC BACK SURFACE OF THE PACKAGE IS NOT ELECTRICALLY CONNECTED TO ANY PART OF THE CIRCUIT. IT CAN BE LEFT FLOATING FOR OPTIMAL ELECTRICAL ISOLATION BETWEEN THE PACKAGE HANDLE AND THE SUBSTRATE OFTIMAL ELECTRICAL ISOLATION BETWEEN THE PACKAGE HANDLE AND THE SUBSTRATE OFTIMAL ELECTRICAL ISOLATION BETWEEN THE PACKAGE HANDLE AND THE SUBSTRATE OF THE DIE. IT CANALSO BE SOLDERED TO GROUND ON THE APPLICATION BOARD IF IMPROVED THERMAL AND/OR MECHANICAL STABILITY IS NEEDED. EXPOSED METAL AT THE CORNERS OF THE PACKAGE IS CONNECTED TO THIS BACK SURFACE. ALLOW SUFFICIENT CLEARANCE FOR 002 06561-( VIAS AND OTHER COMPONENTS.

Figure 2. Pin Configuration

#### **Table 4. Pin Function Descriptions**

Pin No.	Mnemonic	Description
1	D	Noninverting Input.
2	D	Inverting Input.
3, 4, 5, 6, 9, 10	ŃC	No Connect. No physical connection to the die.
7, 14	VEE	Negative Supply Voltage.
8, 13	Vcc	Positive Supply Voltage.
11	Q	Inverting Output.
12	Q	Noninverting Output.
15	VREF	Reference Voltage. Reference voltage for biasing ac-coupled inputs.
16	VT	Center Tap. Center tap of 100 $\Omega$ input resistor.
Heat Sink/ Exposed Pad	NC	No Connect. The metallic back surface of the package is not electrically connected to any part of the circuit. It can be left floating for optimal electrical isolation between the package handle and the substrate of the die. It can also be soldered to ground on the application board if improved thermal and/or mechanical stability is needed. Exposed metal at the corners of the package is connected to this back surface. Allow sufficient clearance for vias and other components.

16561-00F

100M 100-19990

8 L 06561-008

1M

5

6

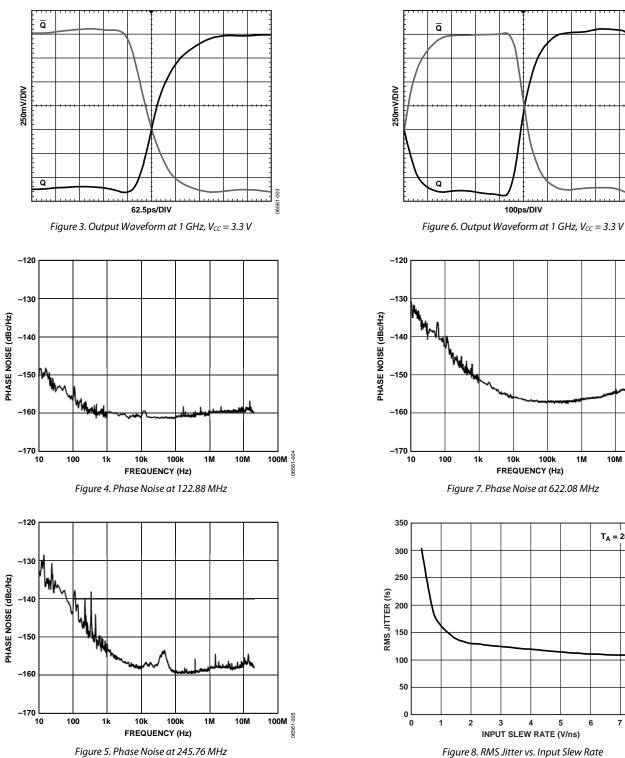
7

10M

T<sub>A</sub> = 25°C

## **TYPICAL PERFORMANCE CHARACTERISTICS**

 $V_{CC}$  = 3.3 V,  $V_{EE}$  = 0 V,  $T_A$  = 25°C. All outputs terminated through 50  $\Omega$  to  $V_{CC}$ , unless otherwise noted.



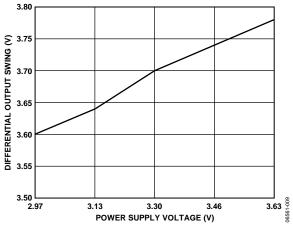


Figure 9. Differential Output Swing vs. Power Supply Voltage

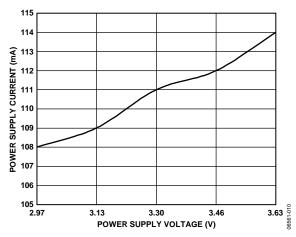
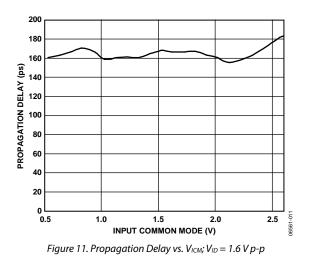


Figure 10. Power Supply Current vs. Power Supply Voltage



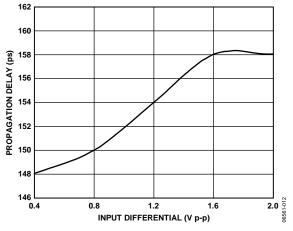


Figure 12. Propagation Delay vs.  $V_{ID}$ ;  $V_{ICM} = 2.15 V$ 

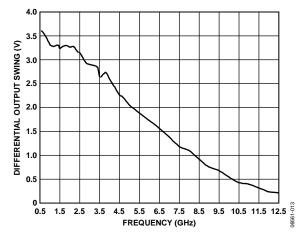


Figure 13. Toggle Rate, Differential Output Swing vs. Frequency

## APPLICATIONS INFORMATION power/ground layout and bypassing

The ADCLK914 buffer is designed for very high speed applications. Consequently, high speed design techniques must be used to achieve the specified performance. It is critically important to use low impedance supply planes for both the negative supply  $(V_{EE})$  and the positive supply  $(V_{CC})$  planes as part of a multilayer board. Providing the lowest inductance return path for switching currents ensures the best possible performance in the target application.

It is also important to adequately bypass the input and output supplies. Place a 1  $\mu$ F electrolytic bypass capacitor within several inches of each power supply pin to ground. In addition, place multiple high quality 0.001  $\mu$ F bypass capacitors as close as possible to each V<sub>EE</sub> and V<sub>CC</sub> supply pin and connect these capacitors to the GND plane with redundant vias. Carefully select high frequency bypass capacitors for minimum inductance and ESR. To maximize the effectiveness of the bypass capacitors at high frequencies, strictly avoid parasitic layout inductance.

Slew currents may also appear at the  $V_{\text{DD}}$  and  $V_{\text{SS}}$  pins of the device being driven by the ADCLK914.

### **HVDS OUTPUT STAGE**

The ADCLK914 has been developed to provide a bipolar interface to any CMOS device that requires extremely low jitter, high amplitude clocks. It is intended to be placed as close as possible to the receiving device and allows the rest of the clock distribution to run at standard CML or PECL levels.

Interconnects must be short and very carefully designed because the single terminated design provides much less margin for error than lower voltage, double terminated transmission techniques.

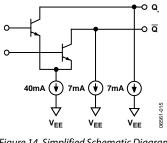


Figure 14. Simplified Schematic Diagram of the ADCLK914 HVDS Output Stage

### **INTERFACING TO HIGH SPEED DACs**

The ADCLK914 is designed to drive high amplitude, low jitter clock signals into high speed, multi-GSPS DACs. The ADCLK914 should be placed as close as possible to the clock input of the DAC so that the high slew rate and high amplitude clock signal that these devices require do not cause routing difficulties, generate EMI, or become degraded by dielectric and other losses. The ADCLK914, in turn, may be driven directly by standard or low swing PECL, CML, CMOS, or LVTTL sources, or by LVDS with simple ac coupling, as illustrated in Figure 15 through Figure 19.

#### **OPTIMIZING HIGH SPEED PERFORMANCE**

As with any high speed circuit, proper design and layout techniques are essential to obtaining the specified performance. Stray capacitance, inductance, inductive power, and ground impedances, as well as other layout issues, can severely limit performance and can cause oscillation. Discontinuities along input and output transmission lines can also severely limit the specified jitter performance by reducing the effective input slew rate.

Input and output matching have a significant impact on performance. The ADCLK914 buffer provides internal 50  $\Omega$  termination resistors for both D and D inputs. The return side can be connected to the reference pin provided or to a current sink at  $V_{CC}$  – 2 V for use with differential PECL, or to  $V_{CC}$  for direct coupled CML. The V<sub>REF</sub> pin should be left floating any time that it is not used to minimize power consumption.

Note that the ADCLK914  $V_{\text{REF}}$  source is current-limited to resist damage from momentary shorts to  $V_{\text{EE}}$  or  $V_{\text{CC}}$  and from capacitor charging currents; for this reason, the  $V_{\text{REF}}$  source cannot be used as a PECL termination supply.

Carefully bypass the termination potential using ceramic capacitors to prevent undesired aberrations on the input signal due to parasitic inductance in the termination return path. If the inputs are directly coupled to a source, care must be taken to ensure that the pins remain within the rated input differential and common-mode ranges.

If the return is floated, the device exhibits 100  $\Omega$  cross-termination, but the source must then control the common-mode voltage and supply the input bias currents.

ESD/clamp diodes between the input pins prevent the application of excessive offsets to the input transistors. ESD diodes are not optimized for best ac performance. If a clamp is needed, it is recommended that appropriate external diodes be used.

#### **RANDOM JITTER**

The ADCLK914 buffer has been specifically designed to minimize random jitter over a wide input range. Provided that sufficient voltage swing is present, random jitter is affected most by the slew rate of the input signal. Whenever possible, clamp excessively large input signals with fast Schottky diodes because attenuators reduce the slew rate. Input signal runs of more than a few centimeters should be over low loss dielectrics or cables with good high frequency characteristics.

### **TYPICAL APPLICATION CIRCUITS**

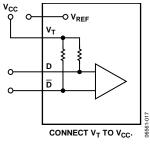


Figure 15. Interfacing to CML Inputs

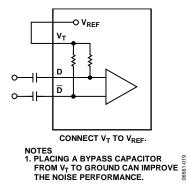


Figure 16. AC Coupling Differential Signals

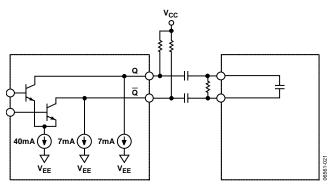


Figure 17. Interfacing to High Speed DAC

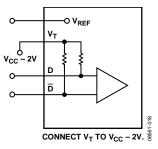
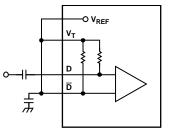


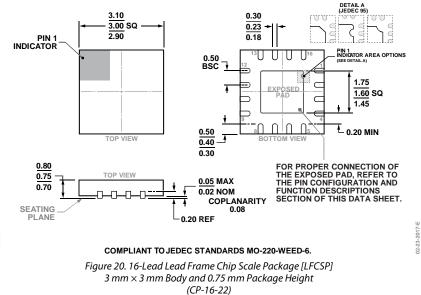
Figure 18. Interfacing to ECL Inputs



CONNECT VT, V<sub>REF</sub>, AND D. PLACE A BYPASS CAPACITOR FROM V<sub>T</sub> TO GROUND. ALTERNATIVELY, V<sub>T</sub>, V<sub>REF</sub>, AND D CAN BE CONNECTED, GIVING A CLEANER LAYOUT AND A 180° PHASE SHIFT.

Figure 19. Interfacing to AC-Coupled, Single-Ended Inputs

## **OUTLINE DIMENSIONS**

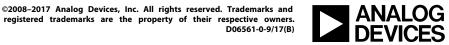


Dimensions shown in millimeters

### **ORDERING GUIDE**

Model <sup>1</sup>	Temperature Range	Package Description	Package Option
ADCLK914BCPZ-WP	-40°C to +125°C	16-Lead Lead Frame Chip Scale Package [LFCSP]	CP-16-22
ADCLK914BCPZ-R7	–40°C to +125°C	16-Lead Lead Frame Chip Scale Package [LFCSP]	CP-16-22
ADCLK914BCPZ-R2	–40°C to +125°C	16-Lead Lead Frame Chip Scale Package [LFCSP]	CP-16-22
ADCLK914/PCBZ		Evaluation Board	

<sup>1</sup> Z = RoHS Compliant Part.



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